

# **Development of a superconducting reference** device for precision thermometry below 1 K

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Abstact A superconducting Reference Device (SRD1000), including 10-12 reference points in the temperature range 10 mK - 1 K is being developed to provide a direct and accurate traceability to the new Provisional Low Temperature Scale (PLTS-2000). Bulk superconductive samples of  $Ir_xRh_{100-x}$  alloys (temperature transition  $T_c$ between 15 and 100 mK), single crystals of Auln<sub>2</sub> ( $T_c$  = 160 mK), AuAl<sub>2</sub> ( $T_c$  = 208 mK) and Zn ( $T_c$  = 850 mK) were prepared, analized and tested. The results of low temperature acceptance tests are presented.

### Experimental set-up at NMi Ultra-low Temperature Superconducting transitions facility

• A gold-plated OHFC copper comparator block was attached to the mixing chamber stage of a <sup>3</sup>He-<sup>4</sup>He dilution refrigerator. A Melting Curve Thermometer cell, a SRM 768 NIST superconductive device and up to • The figures 2 and 3 show examples of the three SRD test devices were mounted on the comparator block (see figure 1).



- The superconducting transitions of the samples included in the SRD test devices were monitored by a dedicated mutual inductance detection system developed by Hightech Development Leiden.
- transitions of respectively AuIn<sub>2</sub>, AuAI<sub>2</sub>, Ir and Ir<sub>80</sub>Rh<sub>20</sub>.



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Figure 1: Experimental set-up.

#### **Results**

• An overview of the reference points and materials selected for the SRD1000 is presented in table 1. Superconducting transition temperatures  $T_c$  and width of the transitions W were measured. The best results obtained thus far are summarised in table 1.

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#### More information

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In case you have specific questions or applications outside this poster, please contact us. We are pleased to provide you with the requested information.

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Table 1: Overview of the proposed PLTS-2000 reference temperatures and best results obtained.

Proposed	Selected metal		Observed	Observed
reference	sample	Sample specification	$T_c$	W
temperature				
[mK]			[mK]	[mK]
1180	Al	4N7 Al foil	1164	8.0
850	Zn	melt 6N Zn shot	850.3	3.0
520	Cd	5N Cd foil	529.3	3.5
250 - 300	Ti/Au bilayer	to be measured	-	-
250 - 300	Mo/Au bilayer	to be measured	-	-
208	AuIn <sub>2</sub>	melt 5N4 Au, 6N In powder	208	0.4
160	AuAl <sub>2</sub>	melt 5N4 Au, 6N Al powder	161.3	0.2
100	Ir	melt 4N5 Ir powder	99.8	0.5
60	$Ir_{92}Rh_{08}$	melt 4N5 Ir, 4N Rh powder	61.3	0.5
35	Ir <sub>80</sub> Rh <sub>20</sub>	melt 4N5 Ir, 4N Rh powder	34.0	0.9
22	Ir <sub>73</sub> Rh <sub>27</sub>	melt 4N5 Ir, 4N Rh powder	20.5	1.5
15	W	4N single crystal	15.5	0.1

**Figure 2**. Transitions of Auln<sub>2</sub> ( $T_c$  = 208.0 mK, W = 0.4 mK) and AuAl<sub>2</sub> ( $T_c$  = 161.3 mK , W = 0.2 mK).



Figure 3. Transitions of Ir ( $T_c$  = 99.8 mK, W = 0.2 mK) and  $Ir_{80}Rh_{20}$  ( $T_c = 34.0 \text{ mK}$ , W = 0.9 mK).

#### **Conclusions and further developments**

- Measurements on samples of Ir<sub>92</sub>Rh<sub>08</sub>, Ir, AuIn<sub>2</sub>, AuAl<sub>2</sub>, Cd, Zn and Al have shown that the base materials selected and preparation techniques allow realize reference developed us to temperatures to support the PLTS-2000 above 50 mK. For these temperatures the reproducibility (defined as 12.5 % of the transition width) is less than 0.1 % of the temperature.
- For the proposed materials preparation techniques are being improved and new samples will be tested.
- Finally a pilot series of SRD1000 will be developed and distributed to various European metrological institutes and industrial partners, which will evaluate this series to determine its suitability as transfer standard for the PLTS-2000.